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10/668,468	09/23/2003	Yong Zhang	50T5646.01	2940

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ROGITZ & ASSOCIATES  
750 B STREET  
SUITE 3120  
SAN DIEGO, CA 92101

EXAMINER
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MALEK, LEILA

ART UNIT	PAPER NUMBER
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2611

MAIL DATE	DELIVERY MODE
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05/30/2007

PAPER

**Please find below and/or attached an Office communication concerning this application or proceeding.**

The time period for reply, if any, is set in the attached communication.

**Office Action Summary**

Application No.

10/668,468

Applicant(s)

ZHANG, YONG

Examiner

Leila Malek

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-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

**Period for Reply**

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

**Status**

- 1) ☒ Responsive to communication(s) filed on 09 March 2007.
- 2a) ☒ This action is **FINAL**. 2b) ☐ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

**Disposition of Claims**

- 4) ☒ Claim(s) 1-17 is/are pending in the application.
- 4a) Of the above claim(s) \_\_\_\_\_ is/are withdrawn from consideration.
- 5) ☐ Claim(s) \_\_\_\_\_ is/are allowed.
- 6) ☒ Claim(s) 1-17 is/are rejected.
- 7) ☐ Claim(s) \_\_\_\_\_ is/are objected to.
- 8) ☐ Claim(s) \_\_\_\_\_ are subject to restriction and/or election requirement.

**Application Papers**

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☒ The drawing(s) filed on 08/02/2004 is/are: a) ☒ accepted or b) ☐ objected to by the Examiner.  
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).  
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

**Priority under 35 U.S.C. § 119**

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some \* c) ☐ None of:
- ☐ Certified copies of the priority documents have been received.
  - ☐ Certified copies of the priority documents have been received in Application No. \_\_\_\_\_.
  - ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

\* See the attached detailed Office action for a list of the certified copies not received.

**Attachment(s)**

- |                                                                                      |                                                                   |
|--------------------------------------------------------------------------------------|-------------------------------------------------------------------|
| 1) <input checked="" type="checkbox"/> Notice of References Cited (PTO-892)          | 4) <input type="checkbox"/> Interview Summary (PTO-413)           |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948) | Paper No(s)/Mail Date. _____                                      |
| 3) <input type="checkbox"/> Information Disclosure Statement(s) (PTO/SB/08)          | 5) <input type="checkbox"/> Notice of Informal Patent Application |
| Paper No(s)/Mail Date _____                                                          | 6) <input type="checkbox"/> Other: _____                          |

## DETAILED ACTION

### ***Response to Arguments***

1. Applicant's arguments filed on 03/09/2007 have been fully considered but they are not persuasive.

**Applicant's Argument:** Applicant argues, on page 7, that since Ebuchi is not directed to jitter, there is no fair prior art suggestion to combine the references as proposed, and even if combined as proposed, claims 1 and 7 would not be reached.

**Examiner's Answer:** Examiner asserts that, although Ebuchi does not expressly disclose jitter reduction; the multiphase clock generator disclosed by Ebuchi comprises a PLL circuit (See Fig. 1). It is well known in the art that PLL circuits normally generate jitter/wander in communication systems, and therefore by removing that jitter (e.g. as suggested by Boerstler) one can improve the performance of the system. Furthermore, the test for obviousness is not whether the features of a secondary reference may be bodily incorporated into the structure of the primary reference; nor is it that the claimed invention must be expressly suggested in any one or all of the references. Rather, the test is what the combined teachings of the references would have suggested to those of ordinary skill in the art. See *In re Keller*, 642 F.2d 413, 208 USPQ 871 (CCPA 1981).

**Applicant's Argument:** Applicant argues, that the rejection of claim 7 is pinned on the unsupported allegation that "it is well known in the art that if data streams have been received in parallel instead of serial, the parts of the data streams that overlap with each other are jitter free.

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**Examiner's Answer:** Examiner asserts that, according to the definition of jitter, it is well known in the art that the parts of the parallel data streams which don't have any phase offset compare to each other are the jitter-free parts of the streams. Therefore, the parts of the data streams that overlap with each other (i.e. don't have any phase offset compare to each other) are the jitter free parts. Based on Boerstler's teaching it would have been obvious to one of ordinary skill in the art at the time of invention to use at least one correction clock pulse in the overlapping time period (i.e. the jitter free time period) to sample the data stream in order to diminish the jitter in the system (see paragraph 0030).

**Applicant's Argument:** Applicant argues, that Wang has been used in the rejection of claim 7 for the proposition that data streams should be sent in parallel instead of serial "to reduce the required processing speed of the phase detector". However, the claims are not directed to reducing processing speed.

**Examiner's Answer:** In response to applicant's argument that Wang has been combined with the other references for a reason other than jitter correction, the fact that applicant has recognized another advantage which would flow naturally from following the suggestion of the prior art cannot be the basis for patentability when the differences would otherwise be obvious. See *Ex parte Obiaya*, 227 USPQ 58, 60 (Bd. Pat. App. & Inter. 1985).

2. Applicant's arguments with respect to claim 12, see page 6, last paragraph, have been considered but are moot in view of the new ground(s) of rejection.

***Claim Rejections - 35 USC § 103***

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

3. Claims 1 and 2 are rejected under 35 U.S.C. 103(a) as being unpatentable over Ebuchi et al. (hereafter, referred as Ebuchi) (US 2001/0030565), in view of Boerstler (US 2002/0172312).

As to claim 1, Ebuchi discloses a multi-phase clock generator (see the abstract and paragraph 0001) for receiving a clock signal (i.e. the reference clock signal RFECLK) defining a clock pulse period (see paragraph 0051 wherein the frequency of the clock signal has been determined); using the clock signal, generating at least one correction clock pulse (see paragraph 0051 and Fig. 3), the correction clock pulse being temporally within a single clock period (see Fig. 4 and paragraph 0051, i.e. since  $T(\text{period})=1/f(\text{frequency})$ ); and frequency of the reference clock signal is 25MHZ and frequency of each of the clock signals is 100 MHZ, therefore the correction clock pulse is within a single clock period). Ebuchi discloses all the subject matters claimed in claim 1, except for using at least one correction clock pulse and latching values in plural data streams. Boerstler, in the same field of endeavor, discloses a system and method for reducing timing uncertainties in a serial data signal (see the abstract). Boerstler discloses a retiming mechanism 205, which has been configured to receive serial data 201 (interpreted as plural data streams) transmitted from the transmitter

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101. Boerstler further discloses that retiming mechanism in receiver 103 may further be configured to receive phase of clock generated from an oscillator 204 and select a particular phase of the clock generated by oscillator 204 to sample serial data 201 during a period of serial data 201 to reduce timing uncertainties, i.e., jitter, in the serial data (See paragraph 0060). It would have been obvious to one of ordinary skill in the art at the time of invention to modify Ebuchi as suggested by Boerstler to sample the data with one of the clocks for the reasons stated above.

As to claim 2, Ebuchi discloses generating at least  $2N$  correction clock pulses for a single clock period, wherein  $N$  is an integer (see Fig. 3 and paragraph 0051).

4. Claims 3, 7, and 8, are rejected under 35 U.S.C. 103(a) as being unpatentable over Ebuchi, and Boerstler, further in view of Wang et al. (US 7,020,227).

As to claim 3, Boerstler further discloses that at least two data streams have respective bits defining a temporally overlapping time period (see Fig. 3, jitter), Ebuchi and Boerstler disclose all the subject matters claimed in claim 3, except that method includes using at least one correction clock pulse in the overlapping time period to latch values in the streams. However, Boerstler discloses that jitter may be diminished by sampling the serial data signal 201 at a point in time when the serial data signal 201 is not likely to experience jitter (see paragraphs 0030 and 0060). It is well known in the art that if the data streams have been received in parallel instead of serial the parts of the data stream that overlap with each other are the jitter free parts (i.e. it means that they do not have any phase offset compare to each other). Therefore, based on Boerstler's teaching it would have been obvious to one of ordinary skill in the art at the

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time of invention to use at least one correction clock pulse in the overlapping time period (i.e. the jitter free time period) to sample the data stream in order to diminish the jitter in the system (see paragraph 0030). Also it would have been obvious to one of ordinary skill in the art at the time of invention to send data streams in parallel instead of serial to reduce the required processing speed of the phase detector (e.g. as evidence by Wang, see column 1, paragraph 4).

As to claim 7, Ebuchi discloses a multi-phase clock generator (see the abstract and paragraph 0001) for receiving a clock signal (i.e. the reference clock signal RFECLK) defining a clock pulse period (see paragraph 0051 wherein the frequency of the clock signal has been determined); using the clock signal, generating at least one correction clock pulse (see paragraph 0051 and Fig. 3), wherein the correction clock signal having a frequency higher than the clock pulse frequency (i.e. 100 MHZ compare to 25 MHZ). Ebuchi discloses all the subject matters claimed in claim 7, except for using at least one correction clock pulse within an overlapping period defined by the at least two bits and latching values of at least two bits in respective data streams. Boerstler, in the same field of endeavor, discloses a system and method for reducing timing uncertainties in a serial data signal (see the abstract). Boerstler discloses a retiming mechanism 205, which has been configured to receive serial data 201 (interpreted as plural data streams) transmitted from the transmitter 101. Boerstler further discloses that retiming mechanism in receiver 103 may further be configured to receive phase of clock generated from an oscillator 204 and select a particular phase of the clock generated by oscillator 204 to sample serial data 201 during a period of

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serial data 201 to reduce timing uncertainties, i.e., jitter, in the serial data (see paragraph 0060). It would have been obvious to one of ordinary skill in the art at the time of invention to modify Ebuchi as suggested by Boerstler to sample the data with one of the clocks for the reasons stated above. Boerstler further discloses that at least two data streams have respective bits defining a temporally overlapping time period (see Fig. 3, jitter), Ebuchi and Boerstler disclose all the subject matters claimed in claim 7, except that the method includes using at least one correction clock pulse in the overlapping time period to latch values in the streams. However, Boerstler discloses that jitter may be diminished by sampling the serial data signal 201 at a point in time when the serial data signal 201 is not likely to experience jitter (see paragraph 0030). It is well known in the art that if the data streams have been received in parallel instead of serial, the parts of the data streams that overlap with each other are the jitter free parts (i.e. it means that they do not have any phase offset compare to each other). Therefore, based on Boerstler's teaching it would have been obvious to one of ordinary skill in the art at the time of invention to use at least one correction clock pulse in the overlapping time period (i.e. the jitter free time period) to sample the data stream in order to diminish the jitter in the system (see paragraph 0030). Also it would have been obvious to one of ordinary skill in the art at the time of invention to send data streams in parallel instead of serial to reduce the required processing speed of the phase detector (e.g. as evidence by Wang, see column 1, paragraph 4).



As to claim 8, Ebuchi discloses that the correction clock module generates at least  $2N$  correction clock pulses for a single clock signal period, wherein  $N$  is an integer (see Fig. 3 and paragraph 0051).

5. Claims 4-6 are rejected under 35 U.S.C. 103(a) as being unpatentable over Ebuchi and Boerstler, further in view of Tang et al. (hereafter, referred as Tang) (US 2002/0056854).

As to claim 4, Ebuchi and Boerstler disclose all the subject matters claimed in claim 1, except that the clock signal is received from a phase locked loop. Tang, in the same field of endeavor, discloses a DLL (Delay Locked Loop) and PLL (Phase Locked Loop), which are used to align a particular signal with the same frequency and phase of a reference clock signal (see paragraph 0003). Tang further discloses that the clock and data recovery circuit 350 includes a PLL for generating a periodic input (interpreted as the reference clock signal) to feed into a DLL (see paragraph 0019). It would have been obvious to one of ordinary skill in the art at the time of invention modify Ebuchi and Boerstler as suggested by Tang to improve the clock and data recovery process (see paragraphs 0008, 0009, and 0020).

As to claim 5, Ebuchi further disclose feeding back an output of the VCO to a phase detector receiving the clock signal (see Fig. 3).

As to claim 6, Ebuchi and Boerstler disclose all the subject matters claimed in claim 1, except for selecting at least one correction clock pulse has been performed by using at least one selector element and at least one de-multiplexer. Tang discloses a phase selector 501 (see Fig. 2 and paragraphs 0021-0023), comprising a control logic

circuit (interpreted as the selector) and a selector (interpreted as the de-multiplexer). It would have been obvious to one of ordinary skill in the art at the time of invention modify Ebuchi and Boerstler as suggested by Tang to improve the clock and data recovery process (see paragraphs 0008, 0009, and 0020).

6. Claims 9, 10, 11, are rejected under 35 U.S.C. 103(a) as being unpatentable over Ebuchi, Boerstler, and Wang, further in view of Tang.

As to claim 9, Ebuchi, Boerstler, and Wang disclose all the subject matters claimed in claim 7, except that the clock signal is received from a phase locked loop. Tang, in the same field of endeavor, discloses a DLL (Delay Locked Loop) and PLL (Phase Locked Loop), which are used to align a particular signal with the same frequency and phase of a reference clock signal (see paragraph 0003). Tang further discloses that the clock and data recovery circuit 350 includes a PLL for generating a periodic input (interpreted as the reference clock signal) to feed into a DLL. It would have been obvious to one of ordinary skill in the art at the time of invention modify Ebuchi, Boerstler, and Wang as suggested by Tang to improve the clock and data recovery process (see paragraphs 0008, 0009, and 0020).

As to claim 10, Ebuchi discloses that an output of the VCO is fed back to a phase detector receiving the clock signal (see Fig. 3).

As to claim 11, Ebuchi, Boerstler, and Wang disclose all the subject matters claimed in claim 11, except for selecting at least one correction clock pulse has been performed by using at least one selector element and at least one de-multiplexer. Tang discloses a phase selector 501 (see Fig. 2 and paragraphs 0021-0023), comprising a

control logic circuit (interpreted as the selector) and a selector (interpreted as the demultiplexer). It would have been obvious to one of ordinary skill in the art at the time of invention modify Ebuchi and Boerstler as suggested by Tang to improve the clock and data recovery process (see paragraphs 0008, 0009, and 0020).

7. Claims 12, 13, and 15-17 are rejected under 35 U.S.C. 103(a) as being unpatentable over Boerstler and Wang, further in view of Parker et al. (hereafter, referred as Parker) (US 5,375,148).

As to claim 12, Boerstler discloses a jitter correction system (see the abstract) comprising: means for generating plural correction clock pulses for each clock pulse of a clock signal (See Fig. 9, block 902); Boerstler discloses all the subject matters claimed in claim 12, except means for correlating at least a first correction clock pulse with at least two data bits received in respective parallel data streams; and means for identifying values of the data bits at least in part using the first correction clock pulse. However, Boerstler discloses that jitter may be diminished by sampling the serial data signal 201 at a point in time when the serial data signal 201 is not likely to experience jitter (see paragraph 0030). It is well known in the art that if the data streams have been received in parallel instead of serial, the parts of the data streams that overlap with each other are the jitter free parts (i.e. it means that they do not have any phase offset compare to each other). Therefore, based on Boerstler's teaching it would have been obvious to one of ordinary skill in the art at the time of invention to use at least one correction clock pulse (i.e. interpreted as correlating at least a first correction clock pulse with at least two data bits received in respective parallel data streams) in the

overlapping time period (i.e. the jitter free time period) to sample (interpreted as identifying values of the data bits at least in part using the first correction clock pulse) the data stream in order to diminish the jitter in the system (see paragraph 0030). Also it would have been obvious to one of ordinary skill in the art at the time of invention to send data streams in parallel instead of serial to reduce the required processing speed of the phase detector (e.g. as evidence by Wang et al. (US 7,020,227), see column 1, paragraph 4). Boerstler and Wang disclose all the subject matters claimed in claim 12, except that the correlation clock pulses are composed of two signals one being the opposite phase of the other. Parker, in the same field of endeavor, discloses phase locked loop circuit (see Fig. 1), wherein the OSCOUT signal is split into opposite phase non-overlapping XCLK and YCLK clock signals by opposite clock generator 22 (see also Fig. 2). It would have been obvious to one of ordinary skill in the art at the time of invention to modify Boerstler and Wang as suggested by Parker to maintain the VCO output at a frequency determined solely by the phase error to the phase detector independent of external influences (see column 1, lines 47-50) and improve the performance of the PLL circuit as the result.

As to claim 13, Boerstler further discloses that means for generating includes at least one voltage controlled oscillator (VCO) (paragraphs 0025 and 0035).

As to claim 15, Boerstler discloses generating at least  $2N$  correction clock pulses for a single clock period, wherein  $N$  is an integer (see paragraph 0028).

As to claim 16, Boerstler discloses that jitter may be diminished by sampling the serial data signal 201 at a point in time when the serial data signal 201 is not likely to

experience jitter (See paragraph 0030). It is well known in the art that if the data streams have been received in parallel instead of serial, parts of the data streams that overlap with each other are the jitter free parts (i.e. it means that they do not have any phase offset compare to each other). Therefore, based on Boerstler's teaching it would have been obvious to one of ordinary skill in the art at the time of invention to use at least one correction clock pulse (i.e. interpreted as correlating at least a first correction clock pulse with at least two data bits received in respective parallel data streams) in the overlapping time period (i.e. the jitter free time period) to sample (interpreted as identifying values of the data bits at least in part using the first correction clock pulse) the data stream in order to diminish the jitter in the system (see paragraph 0030). Also it would have been obvious to one of ordinary skill in the art at the time of invention to send data streams in parallel instead of serial to reduce the required processing speed of the phase detector (for instance as evidence by Wang, see column 1, paragraph 4).

As to claim 17, Boerstler further disclose feeding back an output of the VCO to a phase detector receiving the clock signal (see Fig. 2).

8. Claim 14 is rejected under 35 U.S.C. 103(a) as being unpatentable over Boerstler, Wang, and Parker, further in view of Applicant's background of invention.

As to claim 14, Boerstler, Wang, and Parker disclose all the subject matters claimed in claim 12, except that the means for identifying includes at least one bus latch. Applicant in the background of invention discloses that at the rising or falling edge of each pulse, a device in the receiver referred to as a bus latch samples each stream (See page 1, lines 14-19). It would have been obvious to one of ordinary skill in the art

at the time of invention to sample the received data by a bus latch at the receiver as suggested by the background of invention to sample the parallel data streams at the same time.

### ***Conclusion***

Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Leila Malek whose telephone number is 571-272-8731. The examiner can normally be reached on 9AM-5:30PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Mohammad Ghayour can be reached on 571-272-3021. The fax phone

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number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

Leila Malek  
Examiner  
Art Unit 2611

L.M

  
**MOHAMMED GHAYOUR**  
**SUPERVISORY PATENT EXAMINER**